

Silicon Carbide (SiC) MOSFET - EliteSiC, 40 mohm, 1200 V, M1, Die NTC040N120SC1

Description

Silicon Carbide (SiC) MOSFET uses a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operation frequency, increased power density, reduced EMI, and reduced system size.

Features

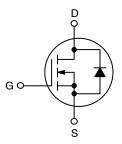
- 1200 V @ $T_J = 175$ °C
- Typ $R_{DS(on)} = 40 \text{ m}\Omega$ at $V_{GS} = 20 \text{ V}$, $I_D = 40 \text{ A}$
- High Speed Switching with Low Capacitance
- 100% UIL Tested
- This Device is Halide Free and RoHS Compliant with exemption 7a, Pb-Free 2LI (on second level interconnection)

Applications

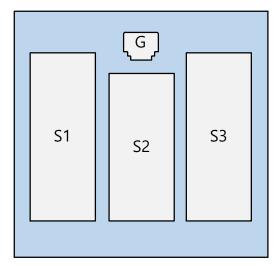
- Industrial Motor Drive
- UPS
- Boost Inverter
- PV Charger

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
1200 V	56 mΩ @ 20 V	60 A	

N-CHANNEL MOSFET



DIE DIAGRAM

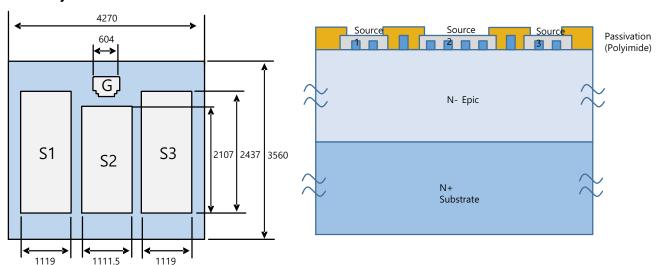


Die Information

 Wafer Diameter 	Diameter 6 inch			
Die Size	4,270 x 3,560 μm			
 Metallization 				
· Top · Back	Ti/TiN/Al Ti/NiV/Ag	5 μm		
• Die Thickness	Typ. 200 μm			
 Gate Pad Size 	604 x 415 μm			

Die Layout

Die Cross Section



Passivation Information

- Passivation Material: Polymide (PSPI)
- Passivation Type: Local Passivation
- Passivation Thickness 10 μm
 - : Passivation Area

Die Layout

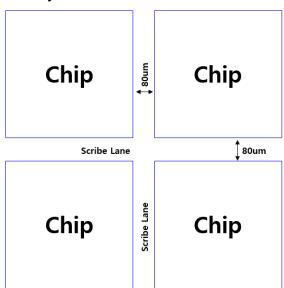


Figure 1. Bare Die Dimensions

MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Parameter Drain-to-Source Voltage Gate-to-Source Voltage			Symbol	Value	Unit
			V _{DSS}	1200	V
			V _{GS}	-15/+25	V
Recommended Operation Values of Gate-to-Source Voltage	T _C < 175°C		V_{GSop}	-5/+20	V
Continuous Drain Current $R_{\theta JC}$	Steady State	T _C = 25°C	I _D	60	Α
Power Dissipation $R_{\theta JC}$	1		P _D	348	W
Continuous Drain Current $R_{\theta JC}$	Steady State	T _C = 100°C	I _D	42	А
Power Dissipation $R_{\theta JC}$	1		P _D	174	W
Pulsed Drain Current (Note 2)	T _C = 25°C		I _{DM}	240	Α
Single Pulse Surge Drain Current Capability	T_C = 25°C, t_p = 10 μs, R_G = 4.7 Ω		I _{DSC}	416	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	34	Α
Single Pulse Drain-to-Source Avalanche Energy ($I_{L(pk)} = 35 \text{ A}$, $L = 1 \text{ mH}$) (Note 3)			E _{AS}	613	mJ

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

	Parameter	Symbol	Value	Unit
Γ	Junction-to-Case (Note 1)	$R_{ heta JC}$	0.43	°C/W

^{1.} The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

^{2.} Repetitive rating, limited by max junction temperature. 3. E_{AS} of 613 mJ is based on starting $T_J = 25^{\circ}C$; L = 1 mH, $I_{AS} = 35$ A, $V_{DD} = 120$ V, $V_{GS} = 20$ V.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA	1200	_	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 1 mA, referenced to 25°C	-	450	-	mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 1200 V, T _J = 25°C	-	-	100	μΑ
		V _{GS} = 0 V, V _{DS} = 1200 V, T _J = 175°C	-	_	250	
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} = +25/-15 V, V _{DS} = 0 V	-	-	±1	μΑ
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(th)}	$V_{GS} = V_{DS}$, $I_D = 10 \text{ mA}$	1.8	2.97	4.3	V
Recommended Gate Voltage	V _{GOP}		-5	_	+20	V
Drain-to-Source On Resistance	R _{DS(on)}	V_{GS} = 20 V, I_{D} = 35 A, T_{J} = 25°C	_	39	56	mΩ
		V _{GS} = 20 V, I _D = 35 A, T _J = 150°C	_	60	-	
Forward Transconductance	9FS	V _{DS} = 20 V, I _D = 35 A	-	20	-	S
CHARGES, CAPACITANCES & GATE	RESISTANCE					
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 800 V	-	1781	-	pF
Output Capacitance	C _{OSS}		-	140	-	
Reverse Transfer Capacitance	C _{RSS}		-	12	_	
Total Gate Charge	Q _{G(tot)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 600 \text{ V}, I_D = 47 \text{ A}$	-	106	-	nC
Threshold Gate Charge	Q _{G(th)}]	_	16	-	
Gate-to-Source Charge	Q _{GS}]	-	34	-	
Gate-to-Drain Charge	Q _{GD}]	_	26	-	
Gate Resistance	R _G	f = 1 MHz	-	2.2	-	Ω
SWITCHING CHARACTERISTICS						•
Turn-On Delay Time	t _{d(on)}	$V_{GS} = -5/20 \text{ V}, V_{DS} = 800 \text{ V},$	-	18	-	ns
Rise Time	t _r	$I_D = 47 \text{ A}, R_G = 4.7 \Omega,$ Inductive Load	-	41	-	
Turn-Off Delay Time	t _{d(off)}]	-	33	-	
Fall Time	t _f]	-	10.4	-	
Turn-On Switching Loss	E _{ON}]	-	1003	-	μJ
Turn-Off Switching Loss	E _{OFF}]	-	247	-	
Total Switching Loss	E _{TOT}]	-	1248	-	
DRAIN-SOURCE DIODE CHARACTER	RISTICS					•
Continuous Drain-to-Source Diode Forward Current	I _{SD}	V _{GS} = -5 V	-	_	34	Α
Pulsed Drain-to-Source Diode Forward Current (Note 2)	I _{SDM}	V _{GS} = -5 V	-	-	240	Α
Forward Diode Voltage	V _{SD}	V _{GS} = -5 V, I _{SD} = 17.5 A	-	3.8	_	V
Reverse Recovery Time	t _{RR}	$V_{GS} = -5/20 \text{ V}, I_{SD} = 47 \text{ A},$	-	24	-	ns
Reverse Recovery Charge	Q _{RR}	dl _S /dt = 1000 A/μs	-	125	-	nC
Reverse Recovery Energy	E _{REC}]	-	8.5	-	μJ
Peak Reverse Recovery Current	I _{RRM}]	-	10.4	-	Α
Charge Time	ta]	-	12.4	-	ns
Discharge Time	t _b]	-	11.6	-	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

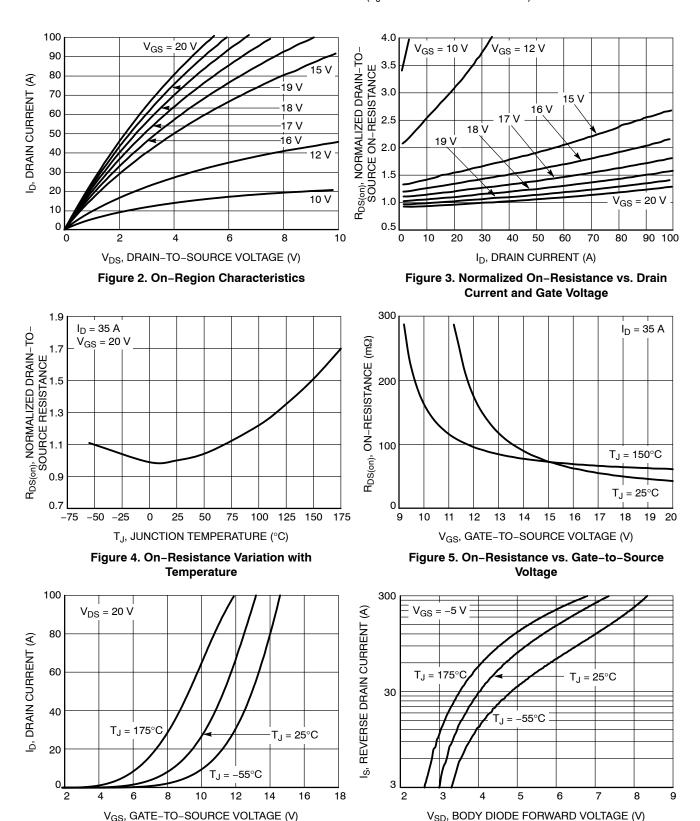
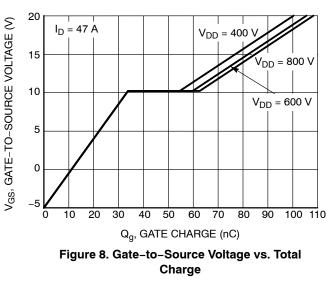


Figure 7. Diode Forward Voltage vs. Current

Figure 6. Transfer Characteristics

TYPICAL CHARACTERISTICS ($T_J = 25$ °C unless otherwise noted) (continued)



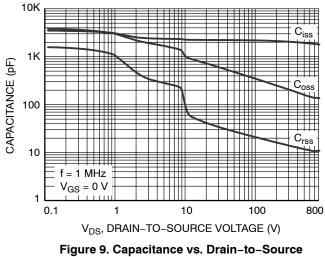


Figure 9. Capacitance vs. Drain-to-Source Voltage

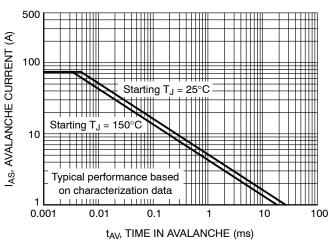


Figure 10. Unclamped Inductive Switching Capability

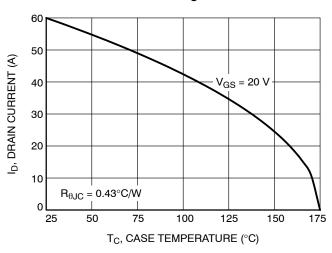


Figure 11. Maximum Continuous Drain Current vs. Case Temperature

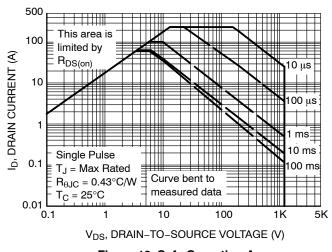


Figure 12. Safe Operating Area

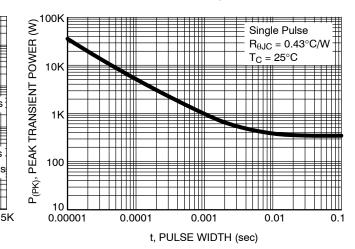


Figure 13. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS ($T_J = 25$ °C unless otherwise noted) (continued)

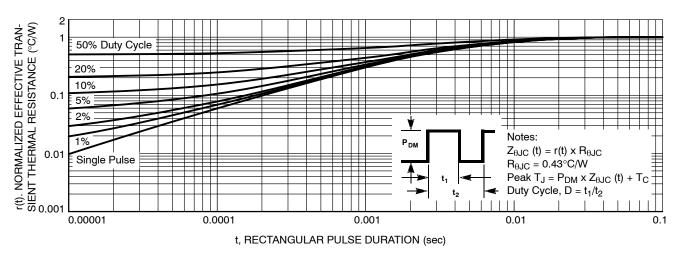


Figure 14. Junction-to-Ambient Thermal Response

ORDERING INFORMATION AND PACKAGE MARKING

Orderable Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity	
NTC040N120SC1	No Marking	Die	Wafer	N/A	N/A	N/A	

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